

2.5V - 2.6V PHASE LOCKED LOOP DIFFERENTIAL 1:10 SDRAM CLOCK DRIVER

FEATURES:

- 1 to 10 differential clock distribution
- Optimized for clock distribution in DDR (Double Data Rate) SDRAM applications
- · Operating frequency: 60MHz to 220MHz
- Very low skew: - <100ps for PC1600 - PC2700
 - <75ps for PC3200
- Very low jitter:
 - <75ps for PC1600 PC2700
 - <50ps for PC3200
- 2.5V AVDD and 2.5V VDDQ for PC1600-PC2700
- 2.6V AVDD and 2.6V VDDQ for PC3200
- CMOS control signal input
- · Test mode enables buffers while disabling PLL
- · Low current power-down mode
- Tolerant of Spread Spectrum input clock
- Available in 48-pin TSSOP, 40-pin VFQFPN, and 56-pin VFBGA packages

APPLICATIONS:

- Meets or exceeds JEDEC standard JESD 82-1A for registered DDR clock driver
- · Meets proposed DDR1-400 specification
- For all DDR1 speeds: PC1600 (DDR200), PC2100 (DDR266), PC2700 (DDR333), PC3200 (DDR400)
- Along with SSTV16857, SSTVF16857, SSTV16859, SSTVM16859, SSTVF16859, DDR1 register, provides complete solution for DDR1 DIMMs

DESCRIPTION:

The CSPT857C is a PLL based clock driver that acts as a zero delay buffer to distribute one differential clock input pair(CLK, \overline{CLK}) to 10 differential output pairs (Y_[0:9], $\overline{Y_{[0:9]}}$) and one differential pair of feedback clock output (FBOUT, FBOUT). External feedback pins (FBIN, \overline{FBIN}) for synchronization of the outputs to the input reference is provided. A CMOS Enable/Disable pin is available for low power disable. When the input frequency falls below approximately 20MHz, the device will enter power down mode. In this mode, the receivers are disabled, the PLL is turned off, and the output clock drivers are tristated, resulting in a current consumption of less than 200 μ A.

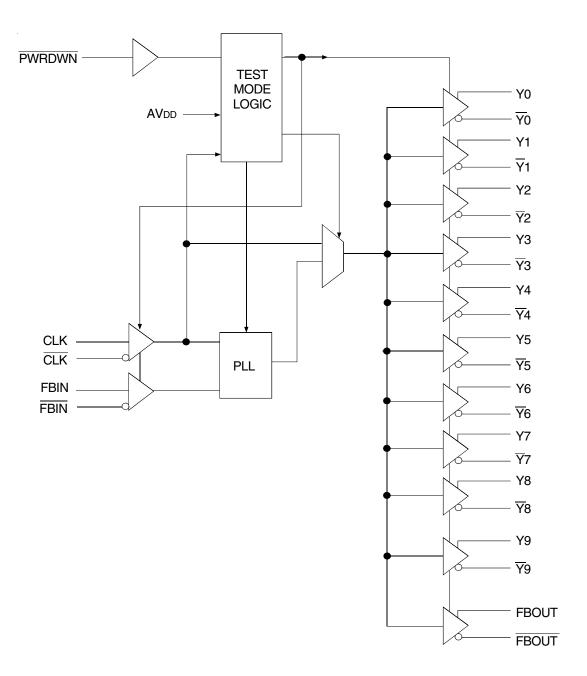
The CSPT857C requires no external components and has been optimised for very low I/O phase error, skew, and jitter, while maintaining frequency and duty cycle over the operating voltage and temperature range. The CSPT857C, designed for use in both module assemblies and system motherboard based solutions, provides an optimum high-performance clock source.

The CSPT857C is available in Commercial Temperature Range (0°C to +70°C) and Industrial Temperature Range (-40°C to +85°C). See Ordering Information for details.

COMMERCIAL AND INDUSTRIAL TEMPERATURE RANGES

1

FUNCTIONAL BLOCK DIAGRAM

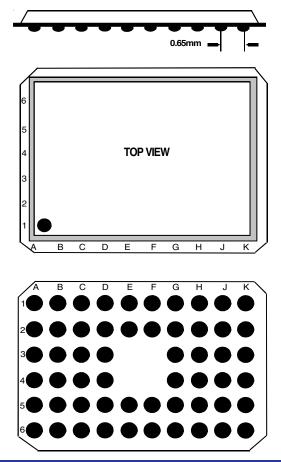


PIN CONFIGURATIONS

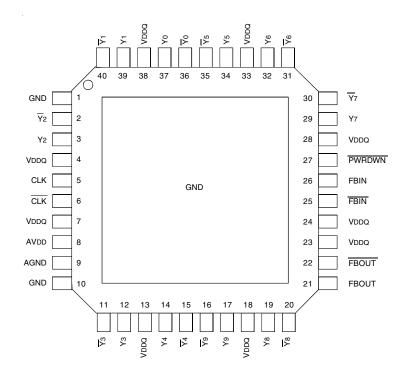
6	Y5	Y6	GND	Y7	PWR DWN	FBIN	VDDQ	FBOUT	Y8	Y9
5	¥5	Y6	GND	¥7	Vddq	FBIN	FBOUT	GND	Y8	¥9
4	GND	Vddq	NC	NC			NC	NC	Vddq	GND
3	GND	Vddq	NC	NC			NC	NC	Vddq	GND
2	Y0	Y1	GND	Y2	VDDQ	CLK	AVDD	GND	Y3	<u>¥4</u>
1	Y0	Y1	GND	Y2	Vddq	CLK	VDDQ	AGND	¥3	Y4
	A	В	С	D	E	F	G	Н	J	K

VFBGA TOP VIEW

56 BALL VFBGA PACKAGE LAYOUT



PIN CONFIGURATIONS



VFQFPN TOP VIEW

ABSOLUTE MAXIMUM RATINGS⁽¹⁾

Symbol	Rating	Max	Unit
Vddq, AVdd	Supply Voltage Range	-0.5 to +3.6	V
VI ⁽²⁾	Input Voltage Range	-0.5 to VDDQ + 0.5	V
Vo ⁽²⁾	Voltage range applied to any	-0.5 to VDDQ + 0.5	V
	output in the high or low state		
Ік	Input Clamp Current	50	mA
(VI <0)			
Іок	Output Clamp Current	±50	mA
(Vo <0 or			
VO > VDDQ)			
lo	Continuous Output Current	±50	mA
(Vo =0 to VDDQ)			
VDDQ or GND	Continuous Current	±100	mA
TSTG	Storage Temperature Range	-65 to +150	°C

NOTES:

		一、 		1	
GND	1	\bigcirc	48		GND
Y ₀	2		47		\overline{Y}_5
Yo	3		46		Y5
VDDQ	4		45		Vddq
Y1	5		44		Y6
<u>Y</u> 1	6		43		\overline{Y}_6
GND	7		42		GND
GND	8		41		GND
<u>Y</u> 2	9		40		<u>¥</u> 7
Y2	10		39		Y 7
VDDQ	11		38		Vddq
VDDQ	12		37		PWRDWN
CLK	13		36		FBIN
CLK	14		35		FBIN
VDDQ	15		34		VDDQ
AVDD	16		33		FBOUT
AGND	17		32		FBOUT
GND	18		31		GND
Y3	19		30		Y 8
Y3	20		29		Y8
VDDQ	21		28		Vddq
Y4	22		27		Y 9
¥4	23		26		Y 9
GND	24		25		GND
		TOCOD			

TSSOP TOP VIEW

CAPACITANCE⁽¹⁾

Parameter Description		Тур.	Max.	Unit
Input Capacitance	2.5	—	3.5	pF
VI = VDDQ or GND				
Delta Input Capacitance	-0.25	—	0.25	pF
VI = VDDQ or GND				
LoadCapacitance	—	14	—	pF
	Input Capacitance VI = VDDQ or GND Delta Input Capacitance VI = VDDQ or GND	Input Capacitance 2.5 VI = VDDQ or GND Delta Input Capacitance -0.25 VI = VDDQ or GND	Input Capacitance 2.5 — VI = VDDQ or GND Delta Input Capacitance -0.25 — VI = VDDQ or GND	Input Capacitance2.5—3.5VI = VDDQ or GND-0.25—0.25VI = VDDQ or GND-0.25—0.25

NOTE:

1. Unused inputs must be held high or low to prevent them from floating.

Stresses greater than those listed under ABSOLUTE MAXIMUM RATINGS may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect reliability.

^{2.} The input and output negative-voltage ratings may be exceeded if the input and output clamp-current ratings are observed.

^{3.} The maximum package power dissipation is calculated using a junction temperature of $150^\circ C$ and a board trace length of 750 mils.

RECOMMENDED OPERATING CONDITIONS

Symbol	Para	ameter	Min.	Тур.	Max.	Unit
AVDD	Supply Voltage		VDDQ-0.12	VDDQ	2.7	V
VDDQ	I/O Supply Voltage PC1600-PC2700		2.3	2.5	2.7	V
		PC3200	2.5	2.6	2.7	
TA	Operating Free-Air Temperat	ure	-40		+85	°C

PIN DESCRIPTION (TSSOP/TVSOP)

Pin Name	Pin Number	Description
AGND	17	Ground for analog supply
AVdd	16	Analog supply
CLK, CLK	13, 14	Differential clock input
FBIN, FBIN	35, 36	Feedback differential clock input
FBOUT, FBOUT	32, 33	Feedback differential clock output
GND	1, 7, 8, 18, 24, 25, 31, 41, 42, 48	Ground
PWRDWN	37	Output enable for Y and \overline{Y}
VDDQ	4, 11, 12, 15, 21, 28, 34, 38, 45	I/O supply
Y[0:9]	3, 5, 10, 20, 22, 27, 29, 39, 44, 46	Buffered output of input clock, CLK
Y[0:9]	2, 6, 9, 19, 23, 26, 30, 40, 43, 47	Buffered output of input clock, CLK

PIN DESCRIPTION (VFBGA)

Pin Name	Pin Number	Description
AGND	H1	Ground for analog supply
AVdd	G2	Analog supply
CLK, CLK	F1, F2	Differential clock input
FBIN, FBIN	F5, F6	Feedback differential clock input
FBOUT, FBOUT	H6, G5	Feedback differential clock output
GND	A3, A4, C1, C2, C5, C6, H2, H5, K3, K4	Ground
PWRDWN	E6	Output enable for Y and \overline{Y}
VDDQ	B3, B4, E1, E2, E5, G1, G6, J3, J4	I/O supply
Y[0:9]	A1, A6, B2, B5, D1, D6, J2, J5, K1, K6	Buffered output of input clock, CLK
Y[0:9]	A2, A5, B1, B6, D2, D5, J1, J6, K2, K5	Buffered output of input clock, CLK

PIN DESCRIPTION (MLF)

Pin Name	Pin Number	Description
AGND	9	Ground for analog supply
AVdd	8	Analog supply
CLK, CLK	5, 6	Differential clock input
FBIN, FBIN	25,26	Feedback differential clock input
FBOUT, FBOUT	21,22	Feedback differential clock output
GND	1, 10	Ground
PWRDWN	27	Output enable for Y and \overline{Y}
VDDQ	4, 7, 13, 18, 23, 24, 28, 33, 38	I/O supply
Y[0:9]	3, 12, 14, 17, 19, 29, 32, 34, 37, 39	Buffered output of input clock, CLK
Y[0:9]	2, 11, 15, 16, 20, 30, 31, 35, 36, 40	Buffered output of input clock, CLK

FUNCTION TABLE⁽¹⁾

INPUTS				OUTPUTS					
AVDD	PWRDWN	CLK	CLK	Y	Ϋ́	FBOUT	FBOUT	PLL	
GND	Н	L	Н	L	Н	L	Н	Bypassed/OFF	
GND	Н	Н	L	Н	L	Н	L	Bypassed/OFF	
Х	L	L	Н	Z	Z	Z	Z	OFF	
Х	L	Н	L	Z	Z	Z	Z	OFF	
Nominal ⁽²⁾	Н	L	Н	L	Н	L	Н	ON	
Nominal ⁽²⁾	Н	Н	L	Н	L	Н	L	ON	
Nominal ^(2,3)	Х	<20MHz	<20MHz	Z	Z	Z	Z	OFF	

NOTES:

1. H = HIGH Voltage Level

L = LOW Voltage Level

Z = High-Impedance OFF-State

X = Don't Care

2. AVDD nominal is 2.5V for PC1600, PC2100, and PC2700. AVDD nominal is 2.6V for PC3200.

3. Additional feature that senses when the clock input is less than approximately 20MHz and places the part in sleep mode. Reciever inputs and PLL are turned off and outputs = tristate.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE FOR PC1600 - PC2700

Following Conditions Apply Unless Otherwise Specified:

Commercial: TA = 0°C to +70°C; Industrial: TA = -40°C to +85°C

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
νικ	Input Clamp Voltage (All Inputs)	VDDQ = 2.3V, II = -18mA		_	-1.2	V
VIL (dc)	Static Input LOW Voltage	PWRDWN	-0.3	—	0.7	V
VIH (dc)	Static Input HIGH Voltage	PWRDWN	1.7	_	VDDQ+0.3	
VIL (ac)	Dynamic Input LOW Voltage	CLK, CLK, FBIN, FBIN	_	_	0.7	V
VIH (ac)	Dynamic Input HIGH Voltage	CLK, CLK, FBIN, FBIN	1.7		VDDQ	
Vol	Output LOW Voltage	AVDD/VDDQ = Min., IOL = $100\mu A$			0.1	V
		AVDD/VDDQ = Min., IOL = 12mA	—		0.6	
Vон	Output HIGH Voltage	AVDD/VDDQ = Min., IOH = -100μ A	Vddq-0.1			V
		AVDD/VDDQ = Min., IOH = -12mA	1.7			
Vix	Input Differential Cross Voltage		Vddq/2-0.2		VDDQ/2+0.2	V
VID(DC) ⁽¹⁾	DC Input Differential Voltage		0.36		VDDQ+0.6	V
VID(AC) ⁽¹⁾	AC Input Differential Voltage		0.7		VDDQ + 0.6	V
lin	InputCurrent	VDDQ = 2.7V, VI = 0V to 2.7V			±10	μA
IDDPD	Power-Down Current on VDDQ and AVDD	AVDD/VDDQ = Max., CLK = 0MHz or PWRDWN = L	_	100	200	μA
IDDQ	Dynamic Power Supply Current on VDDQ	Avdd/Vddq = Max., CLK = $200MHz$, $120\Omega/14pF$		320	360	mA
		AVDD/VDDQ = Max., CLK = $170MHz$, $120\Omega/14pF$		250	300	
IADD	Dynamic Power Supply Current on AVDD	AVDD/VDDQ = Max., CLK = 170MHz	_		12	mA

NOTE:

1. VID is the magnitude of the difference between the input level on CLK and the input level on TLK.

DC ELECTRICAL CHARACTERISTICS OVER OPERATING RANGE FOR PC3200

Following Conditions Apply Unless Otherwise Specified:

Commercial: TA = 0°C to +70°C; Industrial: TA = -40°C to +85°C

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
Vik	Input Clamp Voltage (All Inputs)	VDDQ = 2.5V, II = -18mA			-1.2	V
VIL(dc)	Static Input LOW Voltage	PWRDWN	-0.3		0.7	V
VIH (dc)	Static Input HIGH Voltage	PWRDWN	1.7		VDDQ + 0.3	
VIL(ac)	Dynamic Input LOW Voltage	CLK, CLK, FBIN, FBIN			0.7	V
VIH (ac)	Dynamic Input HIGH Voltage	CLK, CLK, FBIN, FBIN	1.7		Vddq	
Vol	Output LOW Voltage	AVDD/VDDQ = Min., IOL = $100\mu A$			0.1	V
		AVDD/VDDQ = Min., IOL = 12mA	_		0.6	
Vон	Output HIGH Voltage	AVDD/VDDQ = Min., IOH = -100 μ A	Vddq-0.1			V
		AVDD/VDDQ = Min., IOH = -12mA	1.7			
Vix	Input Differential Cross Voltage		VDDQ/2-0.2		Vddq/2+0.2	V
VID(DC) ⁽¹⁾	DC Input Differential Voltage		0.36		Vddq + 0.6	V
VID(AC) ⁽¹⁾	AC Input Differential Voltage		0.7		Vddq + 0.6	V
lin	InputCurrent	VDDQ = 2.7V, VI = 0V to 2.7V			±10	μA
IDDPD	Power-Down Current on VDDQ and AVDD	AVDD/VDDQ = Max., CLK = 0MHz or PWRDWN = L		100	200	μA
IDDQ	Dynamic Power Supply Current on VDDQ	AVDD/VDDQ = Max., $CLK = 200MHz$, $120\Omega/14pF$		320	360	mA
		Avdd/Vddq = Max., CLK = 200MHz, 120Ω/14pF	_	250	300	
IADD	Dynamic Power Supply Current on AVDD	AVDD/VDDQ = Max., CLK = 200MHz			12	mA

NOTE:

1. VID is the magnitude of the difference between the input level on CLK and the input level on CLK.

TIMING REQUIREMENTS FOR PC1600 - PC2700

Symbol	Parameter	Min.	Max.	Unit
fCLK	Operating Clock Frequency ^(1,2)	60	200	MHz
	Application Clock Frequency ^(1,3)	60	200	MHz
tDC	Input Clock Duty Cycle	40	60	%
Ľ	Stabilization Time ⁽⁴⁾		100	μs

NOTES:

1. The PLL will track a spread spectrum clock input.

2. Operating clock frequency is the range over which the PLL will lock, but may not meet all timing specifications.

3. Application clock frequency is the range over which timing specifications apply.

4. Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal after power up.

TIMING REQUIREMENTS FOR PC3200

Symbol	Parameter	Min.	Max.	Unit
fCLK	Operating Clock Frequency ^(1,2)	60	220	MHz
	Application Clock Frequency ^(1,3)	60	220	MHz
tDC	Input Clock Duty Cycle	40	60	%
t.	Stabilization Time ⁽⁴⁾		100	μs

NOTES:

1. The PLL will track a spread spectrum clock input.

2. Operating clock frequency is the range over which the PLL will lock, but may not meet all timing specifications.

3. Application clock frequency is the range over which timing specifications apply.

4. Stabilization time is the time required for the integrated PLL circuit to obtain phase lock of its feedback signal to its reference signal after power up.

SWITCHING CHARACTERISTICS FOR PC1600 - PC2700

Symbol	Description	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Unit
tPLH ⁽¹⁾	LOW to HIGH Level Propagation Delay Time	Test mode, CLK to any output		4.5		ns
tPHL ⁽¹⁾	HIGH to LOW Level Propagation Delay Time	Test mode, CLK to any output		4.5		ns
UIT(PER)	Jitter (period), see figure 6	66MHz	-90		90	ps
		100/ 133/ 167/ 200 MHz	-75		75	1
tjit(CC)	Jitter (cycle-to-cycle), see figure 3	66MHz	-180		180	ps
		100/ 133/ 167/ 200 MHz	-75		75	1
tjit(HPER)	Half-Period Jitter, see figure 7	66MHz	-160		160	ps
		100/ 133/ 167/ 200 MHz	-100		100	1
tSLR(O)	Output Clock Slew Rate (Single-Ended)	100/ 133/ 167/ 200 MHz (20% to 80%)	1		2.5	V/ns
tSLR(I)	Input Clock Slew Rate		1		4	V/ns
t(Ø)	Static Phase Offset, see figure 4 ^(2,3)	66/ 100/ 133/ 167/ 200 MHz	-50		50	ps
tsk(0)	Output Skew, see figure 5				75	ps
tR, tF	Output Rise and Fall Times (20% to 80%)	Load: 120Ω / 14pF	650		900	ps
Vox ⁽⁵⁾	Output Differential Voltage	Differential outputs are terminated	Vddq/2		Vddq/2	V
		with 120 Ω	-0.15		+ 0.15	
The PLL on	the CSPT857 will meet all the above test paramete	rs while supporting SSC synthesizers ⁽⁴⁾ with	the following par	ameters:		
SSC	Modulation Frequency	—	30		50	KHz
SSC	Clock Input Frequency Deviation	—	0		-0.5	%
f3dB	PLL Loop Bandwidth	—		5		MHz

NOTES:

1. Refers to transition of non-inverting output.

2. Static phase offset does not include jitter.

3. $t(\phi)$ is measured with input clock slew rate $t_{SLR}(i) = 2V/ns$ and an input differential voltage VID of 1.75V.

4. The SSC requirements meet the Intel PC100 SDRAM Registered DIMM specification.

5. Vox is specified at the SDRAM clock input or test load.

SWITCHING CHARACTERISTICS FOR PC3200

Symbol	Description	Test Conditions	Min.	Typ. ⁽¹⁾	Max.	Unit
tPLH ⁽¹⁾	LOW to HIGH Level Propagation Delay Time	Test mode, CLK to any output		4.5		ns
tPHL ⁽¹⁾	HIGH to LOW Level Propagation Delay Time	Test mode, CLK to any output		4.5		ns
tJIT(PER)	Jitter (period), see figure 6	66MHz	-90		90	ps
		200 MHz	-50		50	1
tjit(CC)	Jitter (cycle-to-cycle), see figure 3	66MHz	-180		180	ps
		200 MHz	-75		75	1
tJIT(HPER)	Half-Period Jitter, see figure 7	66MHz	-160		160	ps
		200 MHz	-75		75	1
tSLR(O)	Output Clock Slew Rate (Single-Ended)	200 MHz (20% to 80%)	1		2.5	V/ns
tSLR(I)	Input Clock Slew Rate		1		4	V/ns
t(Ø)	Static Phase Offset, see figure 4 ^(2,3)	200 MHz	-50		50	ps
tsk(0)	Output Skew, see figure 5				75	ps
tR,tF	Output Rise and Fall Times (20% to 80%)	Load: 120Ω / 14pF	650		900	ps
Vox ⁽⁵⁾	Output Differential Voltage	Differential outputs are terminated	VDDQ/2		Vddq/2	V
		with 120 Ω	-0.15		+ 0.15	
The PLL on	the CSPT857 will meet all the above test paramete	ers while supporting SSC synthesizers ⁽⁴⁾	with the following par	ameters:		
SSC	Modulation Frequency	-	30	_	50	KHz
SSC	Clock Input Frequency Deviation	_	0		-0.5	%
f3dB	PLL Loop Bandwidth	—	_	5		MHz

NOTES:

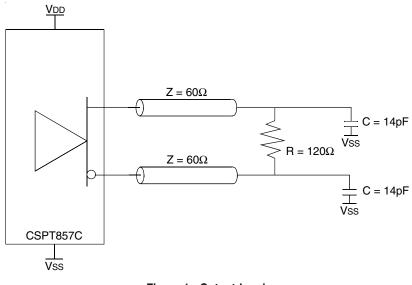
1. Refers to transition of non-inverting output.

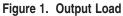
2. Static phase offset does not include jitter.

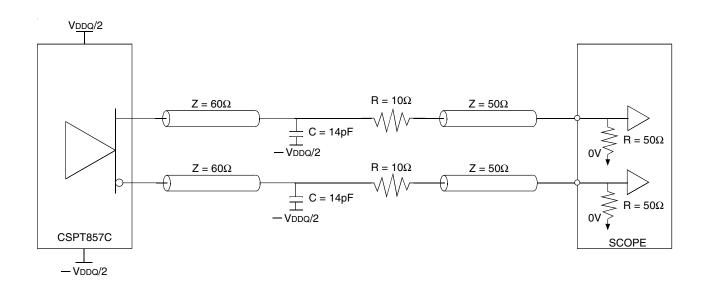
3. $t(\phi)$ is measured with input clock slew rate tsLR(I) = 2V/ns and an input differential voltage VID of 1.75V.

4. The SSC requirements meet the Intel PC100 SDRAM Registered DIMM specification.

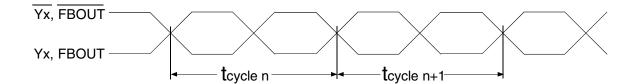
5. Vox is specified at the SDRAM clock input or test load.



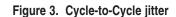


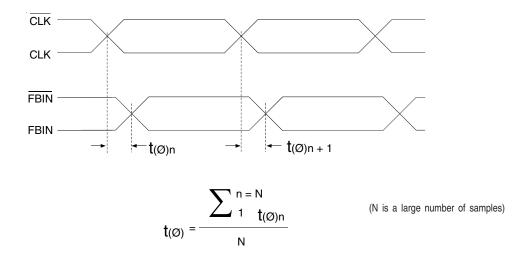




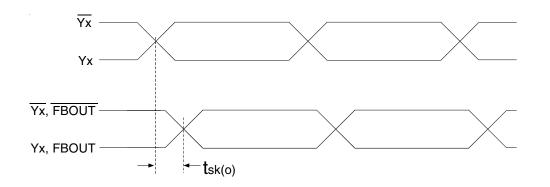


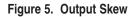
 $t_{jit(cc)} = t_{cycle n} - t_{cycle n+1}$

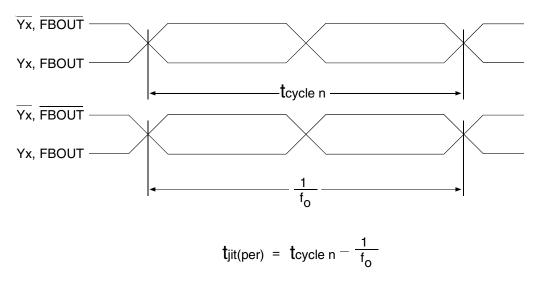


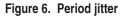












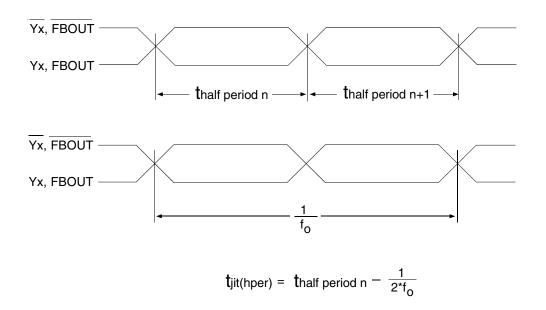


Figure 7. Half-Period jitter

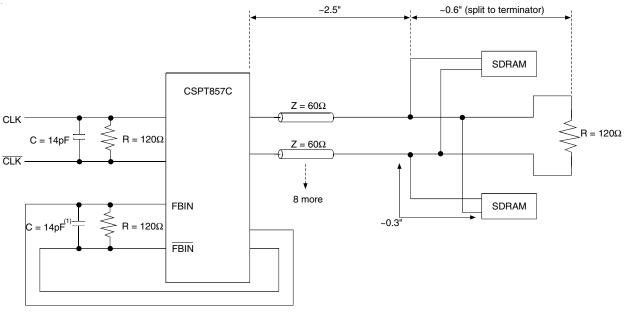




APPLICATION INFORMATION

		Clock Loading on the PLL outputs (pF)		
Clock Structure	# of SDRAM Loads per Clock	Min.	Max.	
#1	2	4	7	
#2	4	8	14	

APPLICATION INFORMATION



Feedback path



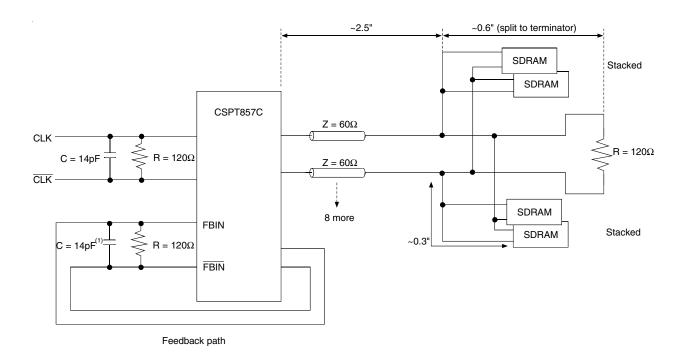
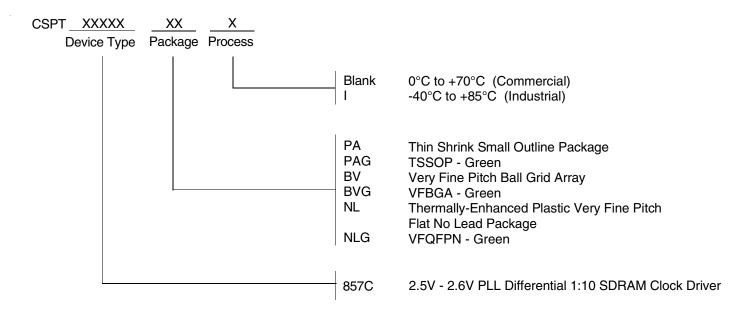


Figure 10. Clock Structure 2

NOTE:

1. Memory module vendors may need to adjust the feedback capacitive load in order to meet DDR SDRAM registered DIMM timing requirements.

ORDERINGINFORMATION



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